

# Search Notes



Application/Control No.

10/649,472

Examiner

Kin-Chan Chen

Applicant(s)/Patent under Reexamination

CHENG ET AL.

Art Unit

1765

## SEARCHED

Class	Subclass	Date	Examiner
438	689	5-6-05	k-cc
	693		
	745		
	756		
438	757		
252	79.1		
252	79.4	5-6-05	k-cc

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Keyword search USPAT, USPG-pub Epo, Jpo, ZBM-TDB.	5-6-05	k-cc
Derwent, inventor search		
peruse parent case 09/981, 436	5-6-05	k-cc